

Preliminary Technical Information

Polar3[™] HiPerFET[™] Power MOSFET

MMIX1F210N30P3

(Electrically Isolated Tab)

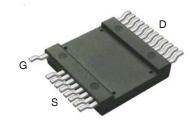
N-Channel Enhancement Mode Avalanche Rated Fast Intrinsic Rectifier

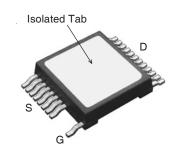


$\begin{array}{c ccccccccccccccccccccccccccccccccccc$	Symbol	Test Conditions	Maximum	Ratings
$\begin{array}{cccccccccccccccccccccccccccccccccccc$	V _{DSS}	$T_{_{\rm J}}$ = 25°C to 150°C	300	V
$\begin{array}{cccccccccccccccccccccccccccccccccccc$	\mathbf{V}_{DGR}	$T_J = 25$ °C to 150°C, $R_{GS} = 1M\Omega$	300	V
$\begin{array}{cccccccccccccccccccccccccccccccccccc$	V _{GSS}	Continuous	±20	V
$\begin{array}{cccccccccccccccccccccccccccccccccccc$	\mathbf{V}_{GSM}	Transient	±30	V
$\begin{array}{c ccccccccccccccccccccccccccccccccccc$		T _C = 25°C	108	Α
$ \begin{array}{llllllllllllllllllllllllllllllllllll$	I _{DM}	$T_{\rm C} = 25^{\circ}$ C, Pulse Width Limited by $T_{\rm JM}$	550	Α
$ \begin{array}{llllllllllllllllllllllllllllllllllll$	I _A		105	Α
$ \begin{array}{llllllllllllllllllllllllllllllllllll$	E _{AS}	T _c = 25°C	4	J
T _J -55 +150 °C T _{JM} 150 °C T _{stg} -55 +150 °C T _L Maximum Lead Temperature for Soldering 300 °C T _{SOLD} 1.6 mm (0.062in.) from Case for 10s 260 °C V _{ISOL} 50/60 Hz, 1 Minute 2500 V~ F _C Mounting Force 50200 / 1145 N/lb		$I_{_{S}} \le I_{_{DM}}, V_{_{DD}} \le V_{_{DSS}}, T_{_{J}} \le 150^{\circ}C$	35	V/ns
$ \begin{array}{cccccccccccccccccccccccccccccccccccc$	P _D	T _C = 25°C	520	W
I _{stg} -55 +150 °C T _L Maximum Lead Temperature for Soldering 300 °C T _{SOLD} 1.6 mm (0.062in.) from Case for 10s 260 °C V _{ISOL} 50/60 Hz, 1 Minute 2500 V∼ F _C Mounting Force 50200 / 1145 N/lb	T _J		-55 +150	
I _{stg} -55 +150 °C T _L Maximum Lead Temperature for Soldering 300 °C T _{SOLD} 1.6 mm (0.062in.) from Case for 10s 260 °C V _{ISOL} 50/60 Hz, 1 Minute 2500 V∼ F _C Mounting Force 50200 / 1145 N/lb	T _{.IM}		150	°C
$\begin{array}{cccccccccccccccccccccccccccccccccccc$	T _{stg}		-55 +150	°C
V _{ISOL} 50/60 Hz, 1 Minute 2500 V~ F _c Mounting Force 50200 / 1145 N/lb		Maximum Lead Temperature for Soldering	300	°C
V _{ISOL} 50/60 Hz, 1 Minute 2500 V~ F _c Mounting Force 50200 / 1145 N/lb	$T_{\mathtt{SOLD}}$	1.6 mm (0.062in.) from Case for 10s	260	°C
F _c Mounting Force 50200 / 1145 N/lb		50/60 Hz, 1 Minute	2500	V~
Weight 8 g		Mounting Force	50200 / 1145	N/lb
	Weight		8	g

Symbol (T _J = 25°C U	Test Conditions nless Otherwise Specified)	Chara Min.	acteristic Typ.	Values Max.	
BV _{DSS}	$V_{GS} = 0V, I_D = 3mA$	300			V
V _{GS(th)}	$V_{DS} = V_{GS}$, $I_{D} = 8mA$	2.5		5.0	V
I _{GSS}	$V_{GS} = \pm 20V, V_{DS} = 0V$			±200	nA
I _{DSS}	$V_{DS} = V_{DSS}, V_{GS} = 0V$ Note 2, $T_{J} = 125$ °C				μA mA
R _{DS(on)}	$V_{GS} = 10V, I_{D} = 105A, Note 1$			16	mΩ

 $V_{DSS} = 300V$ $I_{D25} = 108A$ $R_{DS(on)} \le 16m\Omega$ $t_{max} \le 250ns$





G = Gate D = Drain S = Source

Features

- Silicon Chip on Direct-Copper-Bond Substrate
- High Power Dissipation
- Isolated Mounting Surface
- 2500V~ Electrical Isolation
- Dynamic dv/dt Rating
- Avalanche Rated
- Fast Intrinsic Rectifier
- Low R_{DS(on)}
- Low Drain-to-Tab Capacitance
- Low Package Inductance

Advantages

- Easy to Mount
- Space Savings

Applications

- DC-DC Converters
- Battery Chargers
- Switch-Mode and Resonant-Mode Power Supplies
- Uninterrupted Power Supplies
- AC Motor Drives
- High Speed Power Switching Applications



Symbol	Test Conditions	Characteristic Values		
$(T_J = 25^{\circ}C$	Unless Otherwise Specified)	Min.	Тур.	Max.
g _{fs}	$V_{DS} = 10V, I_{D} = 60A, Note 1$	60	100	S
C _{iss}			16.2	nF
C _{oss}	$V_{GS} = 0V, V_{DS} = 25V, f = 1MHz$		2550	pF
C _{rss}			42	pF
R _{Gi}	Gate Input Resistance		1.0	Ω
t _{d(on)}	Resistive Switching Times		46	ns
t _r	$V_{GS} = 10V, V_{DS} = 0.5 \cdot V_{DSS}, I_{D} = 0.5 \cdot I_{DSS}$		25	ns
t _{d(off)}			94	ns
t _f	$R_{g} = 1\Omega$ (External)		13	ns
$Q_{g(on)}$			268	nC
Q _{gs}	$V_{GS} = 10V$, $V_{DS} = 0.5 \cdot V_{DSS}$, $I_{D} = 0.5 \cdot I_{DSS}$		80	nC
Q_{gd}			72	nC
R _{thJC}				0.24 °C/W
R_{thCS}			0.05	°C/W
R _{thJA}			30	°C/W

Source-Drain Diode

SymbolTest ConditionsCharacteristics $(T_J = 25^{\circ}\text{C Unless Otherwise Specified})$ Min.		cteristic Values Typ. Max.			
I _s	$V_{GS} = 0V$			210	A
I _{SM}	Repetitive, Pulse Width Limited by $T_{_{\rm JM}}$			840	Α
V _{SD}	$I_{\rm F} = 100 {\rm A}, \ V_{\rm GS} = 0 {\rm V}, \ {\rm Note} \ 1$			1.5	V
$\left\{ egin{array}{c} \mathbf{t}_{rr} \\ \mathbf{Q}_{RM} \\ \mathbf{I}_{RM} \end{array} \right\}$	$I_F = 105A$, -di/dt = 100A/ μ s $V_R = 100V$, $V_{GS} = 0V$		4.1 28	250	ns μC Α

Notes:

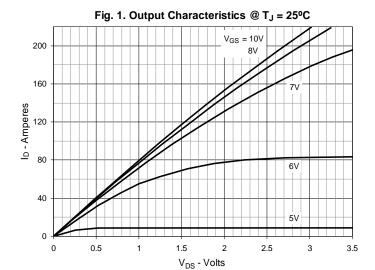
- 1. Pulse test, $t \le 300\mu s$, duty cycle, $d \le 2\%$.
- 2. Part must be heatsunk for high-temp $\mathbf{I}_{\mathrm{DSS}}$ measurement.

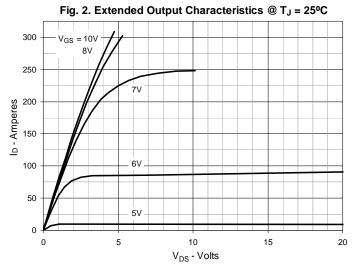
PRELIMANARY TECHNICAL INFORMATION

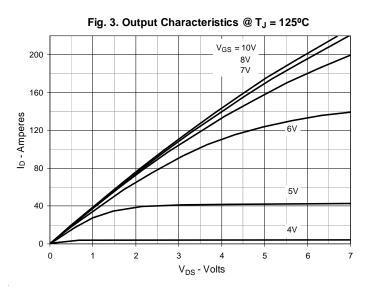
The product presented herein is under development. The Technical Specifications offered are derived from a subjective evaluation of the design, based upon prior knowledge and experience, and constitute a "considered reflection" of the anticipated result. IXYS reserves the right to change limits, test conditions, and dimensions without notice.

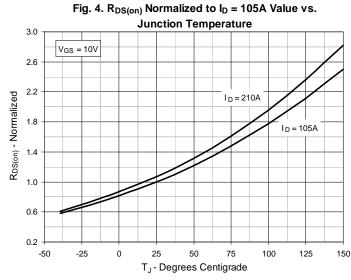
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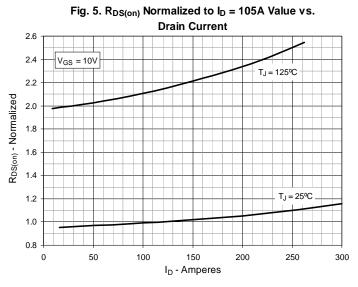


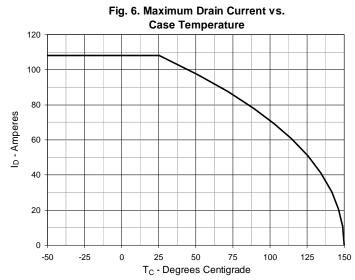






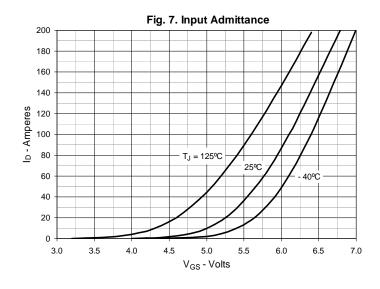


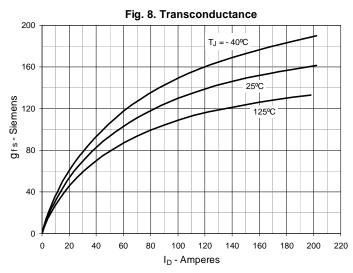


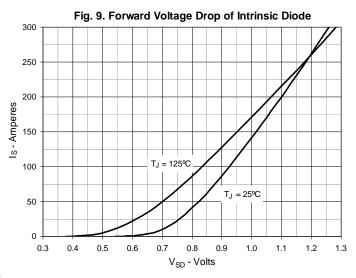


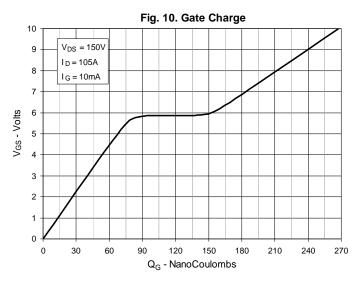
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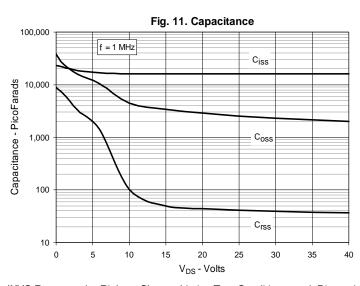


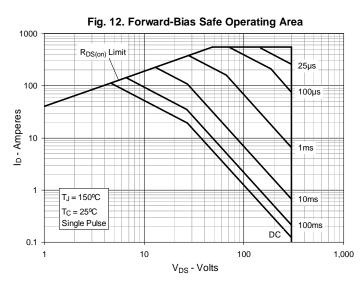












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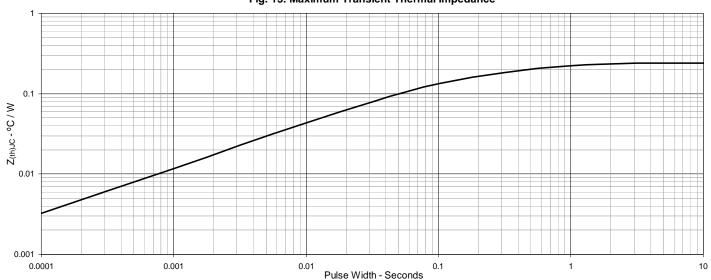
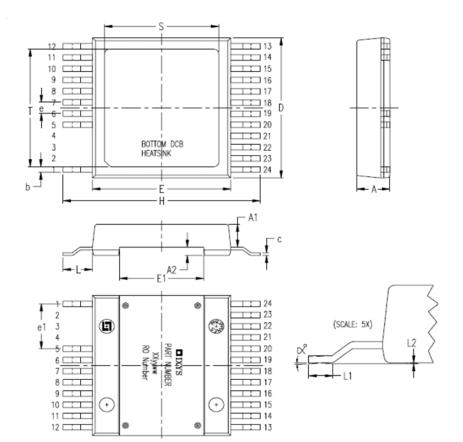


Fig. 13. Maximum Transient Thermal Impedance



Package Outline



SYM	INC	HES	MILLIMETERS	
2114	MIN	MAX	MIN	MAX
Α	.209	.224	5.30	5.70
A1	.154	.161	3.90	4.10
A2	.055	.063	1.40	1.60
b	.035	.045	0.90	1.15
С	.018	.026	0.45	0.65
D	.976	.994	24.80	25.25
E	.898	.915	22.80	23,25
E1	.543	.559	13.80	14.20
е	.079 BSC		2.00 BSC	
e1	.315	.315 BSC		DSC
Н	1.272	1.311	32.30	33,30
L	.181	.209	4.60	5.30
L1	.051	.067	1.30	1.70
L2	.000	.006	0.00	0.15
S	.736	.760	18.70	19.30
Т	.815	.839	20.70	21.30
X	0	4*	0	4*

PIN: 1 = Gate 5-12 = Source 13-24 = Drain

